## Seminar

## **Institute for Plasma Research**

**Title:** Studies on compound semiconductor (ZnGa2Se4)

thin film electronic devices

**Speaker:** Dr. Vishal Dhamecha

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**Date:** 18<sup>th</sup> Nov 2021 (Thursday)

**Time:** 03:30 PM

**Venue:** Online- Join the talk:

https://meet.ipr.res.in/Dr.VishalDhamecha PDFTalk

## **Abstract:**

The synthesis of the evaporant charge of ZnGa2Se4 semiconducting compound is grown by direct fusion method and confirmed by XRD and EDAX. The detailed investigation on growth of ZnGa2Se4 thin films by flash evaporation technique at different substrate temperatures. The influence of the substrate temperatures on the tructure, orientation, composition and stoichiometry of the ZnGa2Se4 thin films are studied by TEM and EDAX. The surface roughness and morphological characteristics of ZnGa2Se4 films deposited at various substrate temperatures studied using AFM. The effect of substrate temperatures on the resistivity, the activation energy for films deposited at different substrate temperatures has been studied. The transmission spectra of the films are used to calculate the absorption coefficient and extinction coefficients and Optical band gaps of ZnGa2Se4 thin films deposited onto glass substrates at various substrate temperatures were investigated. The schottky barrier diode by flash evaporation of ZnGa2Se4 onto pre-deposited film of aluminium with a native oxide layer is fabricated and barrier height of the device was measured using standard current-voltage and capacitance-voltage characteristics are discussed.

Resistive switching and memory effects have been studied on amorphous ZnGa2Se4 thin films. The I-V characteristics and electric pulse induced resistance change of Pt/ZnGa2Se4/Pyrographite/Pt sandwich memory device is measured. Retention behaviour of the memory device confirmed for its use as a non-volatile resistance memory device.